

Spin-torque driven ferromagnetic resonance in a nonlinear regime

W. Chen,¹ G. de Loubens,¹ J.-M. L. Beaujour,¹ J. Z. Sun,² and A. D. Kent¹

¹*Department of Physics, New York University, New York, NY 10003*

²*IBM T. J. Watson Research Center, Yorktown Heights, NY 10598*

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Spin-valve based nanojunctions incorporating Co|Ni multilayers with perpendicular anisotropy were used to study spin-torque driven ferromagnetic resonance (ST-FMR) in a nonlinear regime. Perpendicular field swept resonance lines were measured under a large amplitude microwave current excitation, which produces a large angle precession of the Co|Ni layer magnetization. With increasing rf power the resonance lines broaden and become asymmetric, with their peak shifting to lower applied field. A nonhysteretic step jump in ST-FMR voltage signal was also observed at high powers. The results are analyzed in terms of the foldover effect of a forced nonlinear oscillator and compared to macrospin simulations. The ST-FMR nonhysteretic step response may have applications in frequency and amplitude tunable nanoscale field sensors.

Spin-torque driven ferromagnetic resonance (ST-FMR) has proven to be a powerful technique to investigate magnetic anisotropy, damping and spin-torque interactions in nanometer scale metallic ferromagnets [1, 2, 3, 4]. The method involves injecting an rf current into a laterally confined giant magnetic resistance or magnetic tunnel junction device that drives one of the magnetic layers into resonance. Homodyne mixing of the rf current and device resistance oscillations results in a dc voltage across the device.

In our earlier studies, ST-FMR was conducted on spin valve junctions that incorporate Co|Ni multilayers that have perpendicular magnetic anisotropy and a thick Co reference magnetic layer [5, 6]. The Co|Ni layer magnetic anisotropy was measured with rf currents in the sub-mA range, well below the devices' spin-transfer switching threshold of $\simeq 8$ mA. In these studies the rf current was modulated on and off at a low frequency ($\sim$ kHz), and a lock-in amplifier was used to measure the mixing voltage, V . Measurements were conducted in a linear response regime in which the homodyne signal was proportional to the rf power, i.e. where the field swept resonance line, $V(H)/I_{\text{rf}}^2$ was independent of I_{rf} . Here I_{rf} is the amplitude of the rf current. The resonance lines were symmetric and magnetization precession angles were small (typically around 2° and no more than 6°).

In this Letter we present ST-FMR studies in a nonlinear regime, where the amplitude of the rf current is much larger. The resonance field and the linewidth of the Co|Ni layer have been determined with increasing rf current amplitude and the rf current is not modulated, enabling an investigation of the effect of field sweep direction on the resonance lineshape. We analyze these results with a foldover theory of nonlinear oscillators that predicts a shift in resonance field and a hysteretic response, with a lineshape that depends on the field sweep direction (Fig. 1(b)). We also compare our results to macrospin simulations.

Pillar junctions with a lateral dimension of 50×150 nm² (Fig. 1(a)) were patterned on a silicon wafer using a nanostencil process [7]. Junctions were deposited using metal evaporation with the layer structure || 1.5

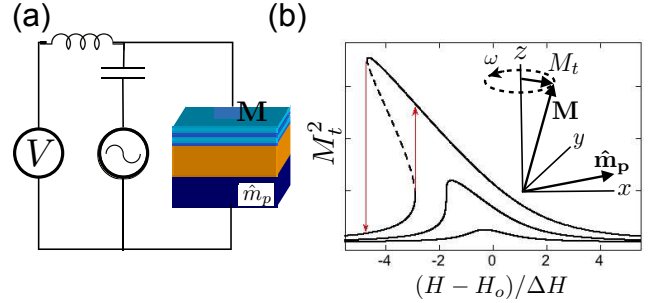


FIG. 1: (a) Sample layer structure and ST-FMR circuit. (b) The foldover effect: precession amplitude vs field at fixed rf frequency for three different normalized rf power levels, $\beta = 0.2\beta_c, \beta_c$ and $3\beta_c$ ($\beta_c = 8/(3\sqrt{3})$). In the last case the curve is multivalued, to the left of the resonance there is a low and high amplitude branch, leading to field sweep direction dependent hysteresis (red arrows). The dashed part of the curve is an unstable oscillation. Inset shows the magnetization configuration. The applied field is in the z direction and the magnetization of the Ni|Co layer precesses about this direction at an angular frequency ω and with a transverse magnetization M_t .

nm Cr| 100 nm Cu| 20 nm Pt| 10 nm Cu| [0.4 nm Co| 0.8 nm Ni] $\times 3$ | 10 nm Cu| 12 nm Co| 200 nm Cu||, where the thin (free) layer is composed of a Co|Ni multilayer and the thick (fixed) layer is pure Co.

ST-FMR measurements were conducted with a magnetic field applied nearly perpendicular (within $\sim 2^\circ$) to the sample surface at room temperature. An rf current generated by a high frequency source is amplified by 20 dB and is added to a dc current using a bias-T (Fig. 1(a)). Positive dc currents are defined such that electrons flow from the free layer to the fixed layer. The magnetoresistance is 2.1% and the pillar resistance is 1.53Ω in the parallel state (Fig. 1(b) of Ref. [5]). The inset of Fig. 1(b) shows the magnetization configuration. With an applied field greater than 0.3 Tesla, the Co|Ni multilayer is magnetized along z , perpendicular to the plane of the layers. However, since the Co layer has a large magnetization, $\mu_0 M_s \simeq 1.5$ T, it remains largely magnetized in plane, as represented by the vector $\hat{m}_p$. rf currents

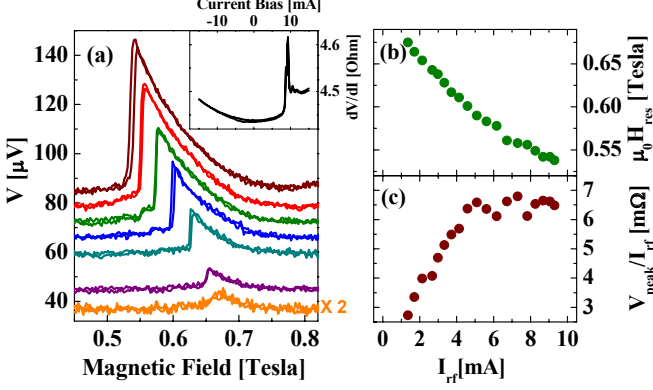


FIG. 2: (a) ST-FMR signal as a function of the applied field at different rf current levels for $f = 16$ GHz. I_{rf} was 1.4, 2.1, 3.3, 4.6, 6.2, 7.8, and 9.0 mA respectively. Each adjacent curve is offset by $10 \mu\text{V}$. The resonance at $I_{\text{rf}}=1.4$ mA is amplified by a factor of 2 above the background of $37 \mu\text{V}$. Inset: dV/dI vs I of at $\mu_0 H=0.675$ T, which is the resonance field at $f=16$ GHz in the linear regime. (b) Magnetic field where the step jump occurs vs I_{rf} . (c) $V_{\text{peak}}/I_{\text{rf}}$ vs I_{rf} . The peak voltage is measured with respect to the baseline background voltage.

cause the magnetization of the Co|Ni multilayer, $\mathbf{M}$, to precess with a transverse amplitude M_t at an angular frequency ω .

ST-FMR was conducted with a constant rf power, and a dc voltmeter was used to measure the mixing voltage. The applied field was swept up and down at a rate 0.12 T/min. Fig. 2(a) shows an example of such measurements. In this case, the rf frequency f is 16 GHz and I_{rf} ranges between 1.4 and 9.0 mA. Each curve is offset by $10 \mu\text{V}$ for clarity. At the lowest rf amplitude ($I_{\text{rf}}=1.4$ mA), there is a $37 \mu\text{V}$ non-resonant background, which we associate with nonlinearities in our measurement circuit. This offset varies with the rf amplitude, which we attribute to other parasitic rectification processes in our measurement circuits, such as slightly non-ohmic contacts and junction heating effects. At $I_{\text{rf}}=1.4$ mA we are in the linear response regime, the lineshape is symmetric, and the resonance field is 0.675 T. The critical current for spin-torque-induced dynamics at this field is ~ 8.5 mA (inset of Fig. 2(a)). The lineshape begins to become asymmetric at $I_{\text{rf}}=2.1$ mA. Starting from $I_{\text{rf}}=3.3$ mA a step jump of the mixing voltage occurs on the lower-field side of the resonance. The maximum ST-FMR voltage increases as I_{rf} increases, and the step-jump field continues to decrease.

The shift of the resonance peak with increasing power can be understood in terms of forced oscillator in which the frequency of oscillator depends on the oscillation amplitude, i.e. the system is a driven anharmonic oscillator. The micromagnetic energy of the free layer can be written as:

$$E = -\mu_0 M_0 m_z H + \frac{1}{2} \mu_0 M_0 M_{\text{eff}} m_z^2, \quad (1)$$

where $m_z = M_z/M_0$ and $M_{\text{eff}} = M_0 - 2K_1/(\mu_0 M_0)$ is the effective easy-plane anisotropy. The first term is the Zeeman energy and the second term is written in terms of M_{eff} , which contains contributions due to shape anisotropy (M_0) and the layer perpendicular magnetic anisotropy (K_1). The resonance condition in this geometry (applied field along z) is given by [8], $2\pi f = \gamma \mu_0 (H_{\text{res}} - M_{\text{eff}} m_z)$, where γ is the gyromagnetic ratio. For a fixed frequency the resonance field is given by:

$$H_{\text{res}} = \frac{2\pi f}{\mu_0 \gamma} + M_{\text{eff}} m_z \quad (2)$$

As the precession amplitude $m_t = M_t/M_0$ increases, the longitudinal component of magnetization, $m_z \simeq 1 - m_t^2/2$, decreases resulting in a shift of the resonance to lower fields ($\mu_0 M_{\text{eff}} \simeq 0.2$ T for our Co|Ni multilayer), as observed in our experiments.

For small rf current amplitudes the lineshape is Lorentzian:

$$m_t^2 = \frac{a I_{\text{rf}}^2}{(H - H_0)^2 + (\Delta H)^2} \quad (3)$$

with a half width at half maximum of $\Delta H = \alpha \omega / (\gamma \mu_0)$, where a is a constant that depends on the spin-torque per unit current and the magnetization direction of the fixed magnetic layer, $\hat{m}_P$. α is the Gilbert damping constant. With increasing precession amplitude one finds [9, 10, 11, 12] to first order in m_t^2 :

$$\tilde{m}_t^2 = \frac{1}{(\tilde{\epsilon} + \beta \tilde{m}_t^2)^2 + 1}. \quad (4)$$

Here $\tilde{m}_t = m_t/m_{t\text{max}}$ is the transverse component of magnetization normalized to the maximum precession amplitude, $m_{t\text{max}}^2 = a I_{\text{rf}}^2 / (\Delta H)^2$; $\tilde{\epsilon} = (H - H_0) / \Delta H$. The resonance peak position is given by: $\tilde{\epsilon} = -\beta = -a M_{\text{eff}} I_{\text{rf}}^2 / [2(\Delta H)^3]$. So the resonance peak position is predicted to shift with the rf power, I_{rf}^2 .

Fig. 1(b) shows a plot of $\tilde{m}$ versus field for three different rf amplitudes. There is a critical value of $\beta_c = 8/(3\sqrt{3}) \simeq 1.54$, which corresponds to the foldover threshold for the excitation amplitude I_{rf} , for which the left side of the resonance curve has a vertical tangent. For sufficiently large current, $\beta > \beta_c$, the resonance curve is multivalued, with two stable/metastable branches differing in amplitude that overlap on the low field side of the resonance in Fig. 1(b). The dashed part of the curve in Fig. 1(b) is an unstable oscillation. As a result hysteresis is predicted in field swept measurements, as indicated by the red arrows in the figure. Hysteresis begins when the shift of the resonance peak is greater than approximately the resonance linewidth ($H_{\text{res}} - H_0 = \beta_c \Delta H$).

The experimental data (Fig. 2(a)) have features qualitatively consistent with the foldover model described above: (1) The resonance lines become asymmetric with increasing power; (2) There is a step jump in ST-FMR voltage above a critical rf amplitude; and (3) The resonance peak position decreases with increasing rf power

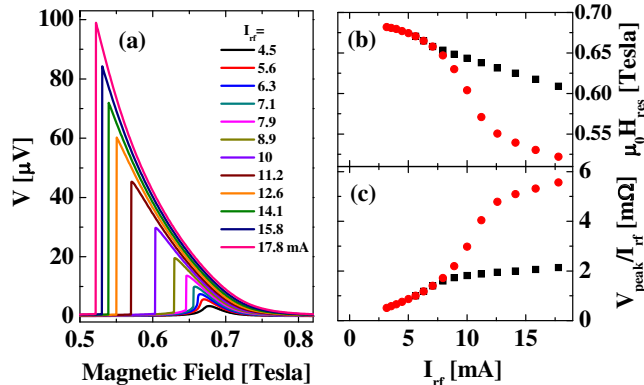


FIG. 3: Macrospin micromagnetic simulations of ST-FMR. (a) Voltage versus applied field for various rf currents, showing the high amplitude branch of the curve. (b) Resonance peak position and (c) $V_{\text{peak}}/I_{\text{rf}}$ vs I_{rf} . The black squares refer to the low amplitude branch and the red circles refer to the high amplitude branch of the resonance curve.

(Fig. 2(b)). However, there are discrepancies with the model, particularly the fact that little hysteresis is observed at large rf amplitudes, when the resonance shift far exceeds the resonance linewidth, $\mu_0 \Delta H = 0.02$ T. Also, the resonance field shifts nearly linearly with increasing rf current.

To further understand the data we have conducted macrospin simulations of the magnetization dynamics with an applied rf current. We take the micromagnetic energy given by Eq. 1 and an angular dependence of the spin-torque and magnetoresistance determined using continuous random matrix theory (CRMT) for our device layer stack [13]. This model has been found to give spin-torques in agreement with those found in our experiments conducted in the linear response regime [5]. The torque is parameterized by $\tau_{\text{ST}} = Ik(\theta)(\hbar/2e)\hat{m} \times (\hat{m} \times \hat{m}_p)$ with $k(\theta) = (a + b \sin \theta)/(c + d \cos \theta)$ ($a = 1.98$, $b = 7.11$, $c = 28.74$, $d = 25.95$). The results of our simulations are shown in Fig. 3. The high amplitude branch, which extends to lower field, is shown in Fig. 3(a). The resonance line shapes are similar to those observed in experiment. Fig. 3(b) shows the shift of the peak position for both of high and low amplitude branches as well as the peak voltage. For large I_{rf} the resonance peak po-

sition shifts linearly with I_{rf} and $V_{\text{peak}}/I_{\text{rf}}$ saturates at large I_{rf} (Fig. 3(c)), as seen in experiment. The main discrepancy is that larger rf currents are needed to produce the resonance shifts observed.

It also appears that the resonance at high rf currents follows the high amplitude branch independently of the field sweep direction. The evidence for this is the following. First, little to no hysteresis is observed. Second, the resonance shift far exceeds the linewidth as well as the resonance shift found for the low amplitude branch in micromagnetic simulations (Fig. 3(b)). We suspect that there are thermally driven transitions between these dynamical states that excite the high amplitude branch and reduce the hysteresis. The rf current may also heat the device reducing the magnetization of the free layer, increasing thermal fluctuations and leading to a larger shift of the resonance peak position with rf current than seen in the macrospin model. We also note that our analysis and macrospin simulations assume that the damping does not depend on precession amplitude. However, it has been noted that the damping may be nonlinear and this may play a role in understanding the large amplitude ST-FMR driven magnetization dynamics [14].

It is interesting to estimate the maximum precession angle, θ_{max} . This can be done using the voltage peak as well as maximum resonance shift. The peak mixing voltage is given by $V = \frac{1}{4} \Delta R I_{\text{rf}} \sin \eta \sin \theta_{\text{max}}$, where ΔR is the junction magnetoresistance and η is the angle between the layers with no rf current applied ($\eta \simeq 70^\circ$, in these experiments). The precession angle can also be estimated from the shift of the resonance field using Eq. 2. Both approaches give $\theta_{\text{max}} \sim 65^\circ$ at $I_{\text{rf}} = 9.3$ mA, the largest rf current applied in the junction.

In sum, these results illustrate that large rf currents can drive nonlinear magnetization dynamics, characteristic of any driven anharmonic oscillator. The observed nonhysteretic step response may prove useful for rf frequency and amplitude tunable nanometer scale field sensors. It will also be interesting to compare these results to full micromagnetic simulations as well as to further explore the role of thermal fluctuations on ST-FMR foldover phenomena.

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